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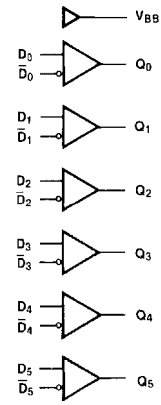
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Truth Table

Inputs		Outputs
D_n	\overline{D}_n	Q_n
L	H	L
H	L	H
L	L	L
H	H	L
OPEN	OPEN	L
V_{EE}	V_{EE}	L
L	V_{BB}	L
H	V_{BB}	H
V_{BB}	L	H
V_{BB}	H	L

H = HIGH Voltage Level
L = LOW Voltage Level

Logic Diagram



Absolute Maximum Ratings ^(Note 1)				Recommended Operating Conditions					
Storage Temperature (T_{STG})	-65°C to +150°C			Case Temperature (T_C)	Commercial 0°C to +85°C				
Maximum Junction Temperature (T_J)	+150°C			Industrial	-40°C to +85°C				
V_{EE} Pin Potential to Ground Pin	-7.0V to +0.5V			Supply Voltage (V_{EE})	-5.7V to -4.2V				
V_{TTL} Pin Potential to Ground Pin	-0.5V to +6.0V								
Input Voltage (DC)	V_{EE} to +0.5V								
Voltage Applied to Output									
in HIGH State (with $V_{CC} = 0V$)	-0.5V to V_{CC}								
Current Applied to Output									
in LOW State (Max)	twice the rated I_{OL} (mA)								
ESD (Note 2)	≥2000V								
<p>Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.</p> <p>Note 2: ESD testing conforms to MIL-STD-883, Method 3015.</p>									
Commercial Version									
DC Electrical Characteristics									
$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $5.5V$, $T_C = 0°C$ to $+85°C$ (Note 3)									
Symbol	Parameter	Min	Typ	Max	Units	Conditions			
V_{BB}	Output Reference Voltage	-1380	-1320	-1260	mV	$I_{VBB} = -2.1$ mA			
V_{IH}	Single-Ended Input HIGH Voltage	-1165		-870	mV	Guaranteed HIGH Signal for All Inputs (with One Input Tied to V_{BB})			
V_{IL}	Single-Ended Input LOW Voltage	-1830		-1475	mV	Guaranteed LOW Signal for All Inputs (with One Input Tied to V_{BB})			
V_{OH}	Output HIGH Voltage	2.5			V	$I_{OH} = -2.0$ mA	$V_{IN} = V_{IH} (Max)$		
V_{OL}	Output LOW Voltage			0.5	V	$I_{OL} = 20$ mA	or $V_{IL} (Min)$		
V_{DIFF}	Input Voltage Differential	150			mV	Required for Full Output Swing			
V_{CM}	Common Mode Voltage	$V_{CC} - 2.0$		$V_{CC} - 0.5$	V				
I_{IH}	Input HIGH Current			350	μA	$V_{IN} = V_{IH} (Max)$, $D_0-D_5 = V_{BB}$, $\bar{D}_0-\bar{D}_5 = V_{IL} (Min)$			
I_{IL}	Input LOW Current	0.5			μA	$V_{IN} = V_{IL} (Min)$, $D_0-D_5 = V_{BB}$			
I_{OS}	Output Short-Circuit Current	-150		-60	mA	$V_{OUT} = GND$ (Note 4)			
I_{EE}	V_{EE} Power Supply Current	-37	-27	-17	mA	$D_0-D_5 = V_{BB}$			
I_{TTL}	V_{TTL} Power Supply Current		45	65	mA	$D_0-D_5 = V_{BB}$			
<p>Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.</p> <p>Note 4: Test one output at a time.</p>									
DIP AC Electrical Characteristics									
$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$									
Symbol	Parameter	$T_C = 0°C$		$T_C = +25°C$		$T_C = +85°C$		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t_{PLH}	Propagation Delay							ns	$C_L = 15$ pF Figures 1, 2
t_{PHL}	Data to Output	0.80	3.50	0.90	3.70	1.00	4.00		
t_{PLH}	Propagation Delay							ns	$C_L = 50$ pF Figures 1, 3
t_{PHL}	Data to Output	1.60	4.30	1.70	4.50	1.80	4.80		

Commercial Version (Continued) SOIC and PLCC AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$

Symbol	Parameter	$T_C = 0^\circ C$		$T_C = +25^\circ C$		$T_C = +85^\circ C$		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t_{PLH} t_{PHL}	Propagation Delay Data to Output	0.80	3.30	0.90	3.50	1.00	3.80	ns	$C_L = 15$ pF Figures 1, 2
t_{PLH} t_{PHL}	Propagation Delay Data to Output	1.60	4.10	1.70	4.30	1.80	4.60	ns	$C_L = 50$ pF Figures 1, 3
t_{OSHL}	Maximum Skew Common Edge Output-to-Output Variation Data to Output Path		0.65		0.65		0.65	ns	PLCC Only (Note 5)
t_{OSLH}	Maximum Skew Common Edge Output-to-Output Variation Data to Output Path		0.65		0.65		0.65	ns	PLCC Only (Note 5)
t_{OST}	Maximum Skew Opposite Edge Output-to-Output Variation Data to Output Path		2.20		2.20		2.20	ns	PLCC Only (Note 5)
t_{PS}	Maximum Skew Pin (Signal) Transition Variation Data to Output Path		2.10		2.10		2.10	ns	PLCC Only (Note 5)

Note 5: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.

Industrial Version

PLCC DC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $T_C = -40^{\circ}C$ to $+85^{\circ}C$ (Note 6)

Symbol	Parameter	$T_C = -40^{\circ}C$		$T_C = 0^{\circ}C$ to $+85^{\circ}C$		Units	Conditions
		Min	Max	Min	Max		
V_{BB}	Output Reference Voltage	-1395	-1255	-1380	-1260	mV	$I_{V_{BB}} = -2.1$ mA
V_{IH}	Single-Ended Input HIGH Voltage	-1170	-870	-1165	-870	mV	Guaranteed HIGH Signal for All Inputs (with One Input Tied to V_{BB})
V_{IL}	Single-Ended Input LOW Voltage	-1830	-1480	-1830	-1475	mV	Guaranteed LOW Signal for All Inputs (with One Input Tied to V_{BB})
V_{OH}	Output HIGH Voltage	2.5		2.5		V	$I_{OH} = -2.0$ mA
V_{OL}	Output LOW Voltage		0.5		0.5	V	$I_{OL} = 20$ mA
V_{DIFF}	Input Voltage Differential	150		150		mV	Required for Full Output Swing
V_{CM}	Common Mode Voltage	$V_{CC} - 2.0$	$V_{CC} - 0.5$	$V_{CC} - 2.0$	$V_{CC} - 0.5$	V	
I_{IH}	Input HIGH Current		450		350	μ A	$V_{IN} = V_{IH} (Max)$, $D_0-D_5 = V_{BB}$, $\bar{D}_0-\bar{D}_5 = V_{IL} (Min)$
I_{IL}	Input LOW Current	0.5		0.5		μ A	$V_{IN} = V_{IL} (Min)$, $D_0-D_5 = V_{BB}$
I_{OS}	Output Short-Circuit Current	-150	-60	-150	-60	mA	$V_{OUT} = GND$ (Note 7)
I_{EE}	V_{EE} Power Supply Current	-37	-15	-37	-17	mA	$D_0-D_5 = V_{BB}$
I_{TTL}	V_{TTL} Power Supply Current		65		65	mA	$D_0-D_5 = V_{BB}$

Note 6: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

Note 7: Test one output at a time.

PLCC AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$

Symbol	Parameter	$T_C = -40^{\circ}C$		$T_C = +25^{\circ}C$		$T_C = +85^{\circ}C$		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t_{PLH}	Propagation Delay Data to Output	0.80	3.30	0.90	3.50	1.00	3.80	ns	$C_L = 15$ pF Figures 1, 2
t_{PLH}	Propagation Delay Data to Output	1.60	4.10	1.70	4.30	1.80	4.60	ns	$C_L = 50$ pF Figures 1, 3

Switching Waveform

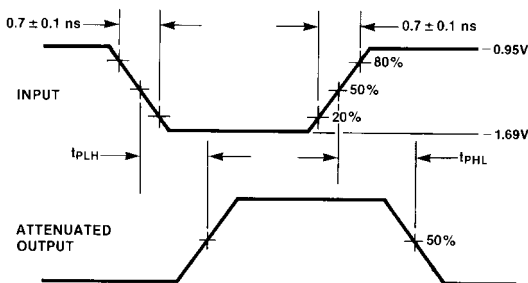
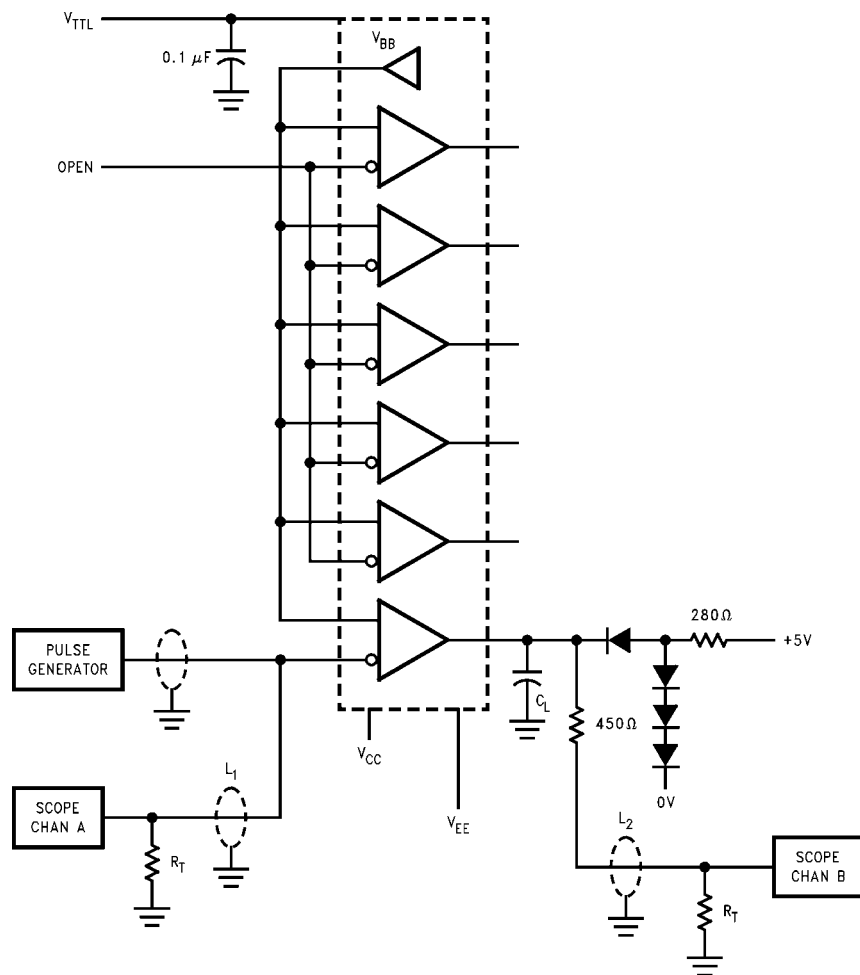


FIGURE 1. Propagation Delay

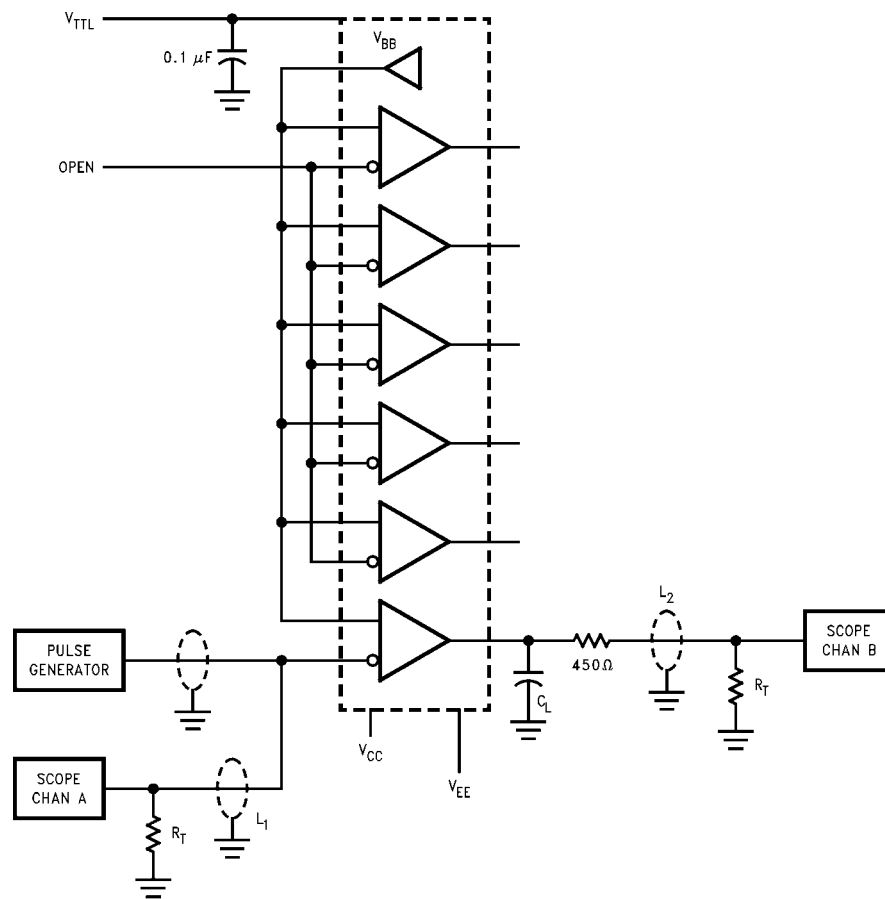
Test Circuits

**Note:**

- $V_{CC} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5V$
- $L1$ and $L2$ = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling $0.1 \mu F$ from GND to V_{CC} , V_{EE} and V_{TTL}
- All unused outputs are loaded with 500Ω to GND
- C_L = Fixture and stray capacitance = 15 pF

FIGURE 2. AC Test Circuit for 15 pF Loading

Test Circuits (Continued)

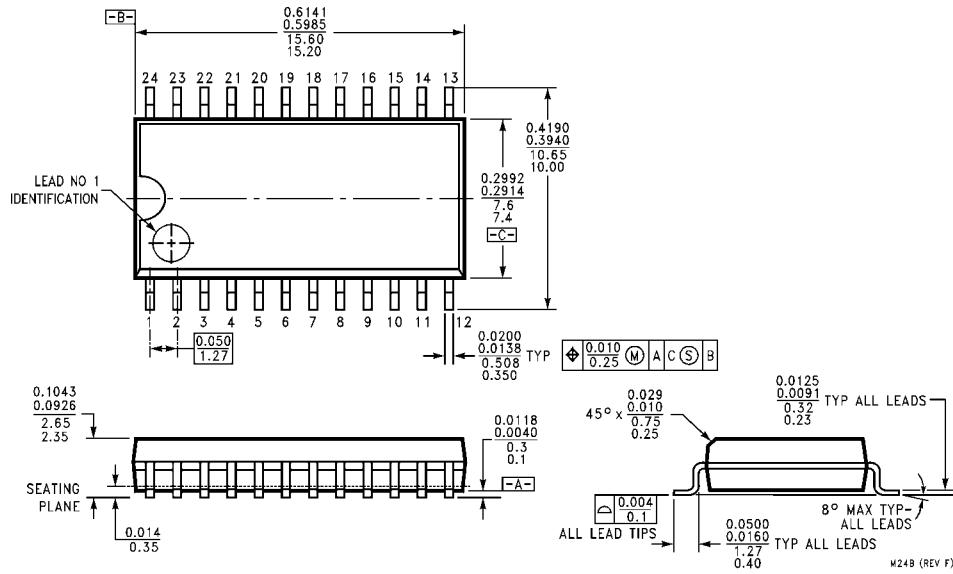


Note:

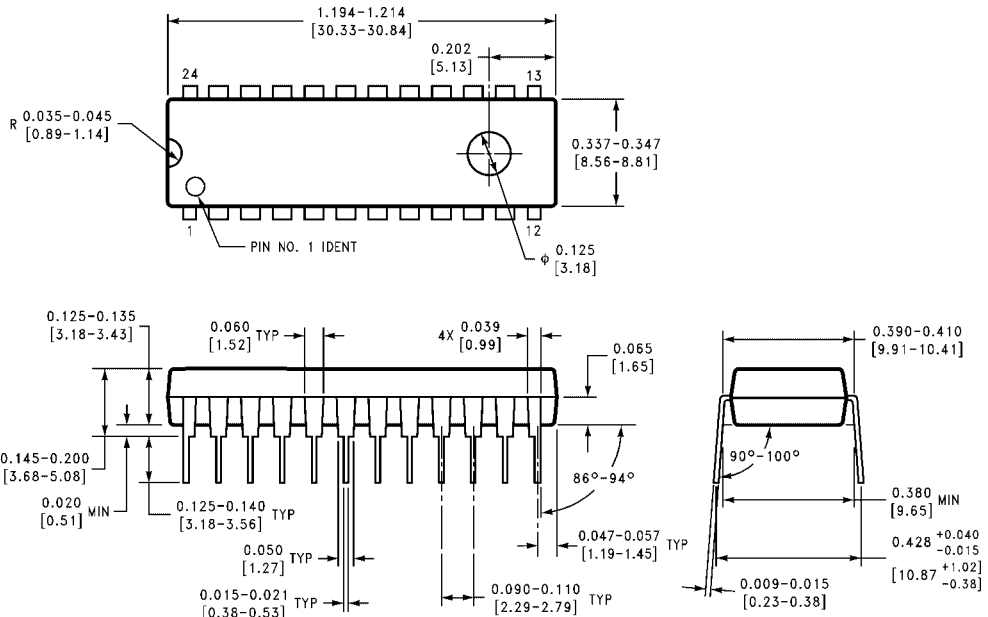
- $V_{CC} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5V$
- L_1 and L_2 = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling $0.1 \mu F$ from GND to V_{CC} , V_{EE} and V_{TTL}
- All unused outputs are loaded with 500Ω to GND
- C_L = Fixture and stray capacitance = $50 pF$

FIGURE 3. AC Test Circuit for 50 pF Loading

Physical Dimensions inches (millimeters) unless otherwise noted

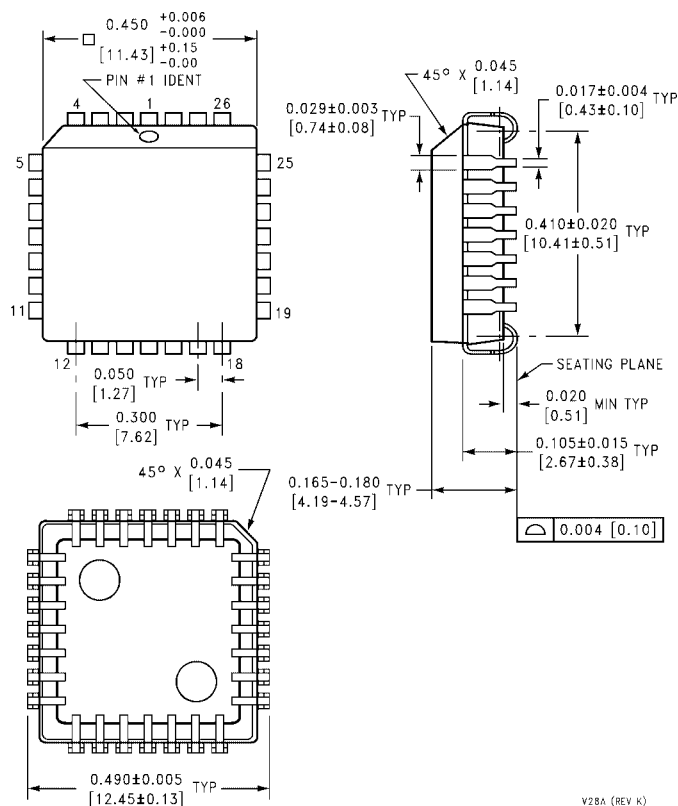


**24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M24B**



**24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide
Package Number N24E**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
Package Number V28A**

V28A (REV K)

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